

Search Notes

Application/Control No.

10/522,202

Examiner

Shih-Chao Chen

Applicant(s)/Patent under
Reexamination

MARTIN ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
343	742, 867, 895	7/15/2007	CHEN
340	572,1	7/15/2007	CHEN
235	492	7/15/2007	CHEN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (See attached printout).	7/15/2007	CHEN